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Kind regards,

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74LVT16500A

3.3 V 18-bit universal bus transceiver; 3-state

Rev. 03 — 29 May 2006

Product data sheet

1. General description

The 74LVT16500A is a high-performance BiCMOS product designed for V_{CC} operation at 3.3 V.

This device is an 18-bit universal transceiver featuring non-inverting 3-state bus compatible outputs in both send and receive directions. Data flow in each direction is controlled by output enable (OEAB and \overline{OEBA}), latch enable (LEAB and LEBA), and clock (CPAB and CPBA) inputs. For A-to-B data flow, the device operates in the transparent mode when LEAB is HIGH. When LEAB is LOW, the A data is latched if \overline{CPAB} is held at a HIGH or LOW logic level. If LEAB is LOW, the A-bus data is stored in the latch/flip-flop on the HIGH-to-LOW transition of \overline{CPAB} . When OEAB is HIGH, the outputs are active. When OEAB is LOW, the outputs are in the high-impedance state.

Data flow for B-to-A is similar to that of A-to-B but uses \overline{OEBA} , LEBA and \overline{CPBA} . The output enables are complimentary (OEAB is active HIGH, and \overline{OEBA} is active LOW).

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

2. Features

- 18-bit bidirectional bus interface
- 3-state buffers
- Output capability: +64 mA and -32 mA
- TTL input and output switching levels
- Input and output interface capability to systems at 5 V supply
- Bus-hold data inputs eliminate the need for external pull-up resistors to hold unused inputs
- Live insertion/extraction permitted
- Power-up reset
- Power-up 3-state
- No bus current loading when output is tied to 5 V bus
- Negative edge-triggered clock inputs
- Latch-up protection:
 - ◆ JESD78: exceeds 500 mA
- ESD protection:
 - ◆ MIL STD 883 Method 3015: exceeds 2000 V
 - ◆ CDM JESD22-C101-C exceeds 1000 V

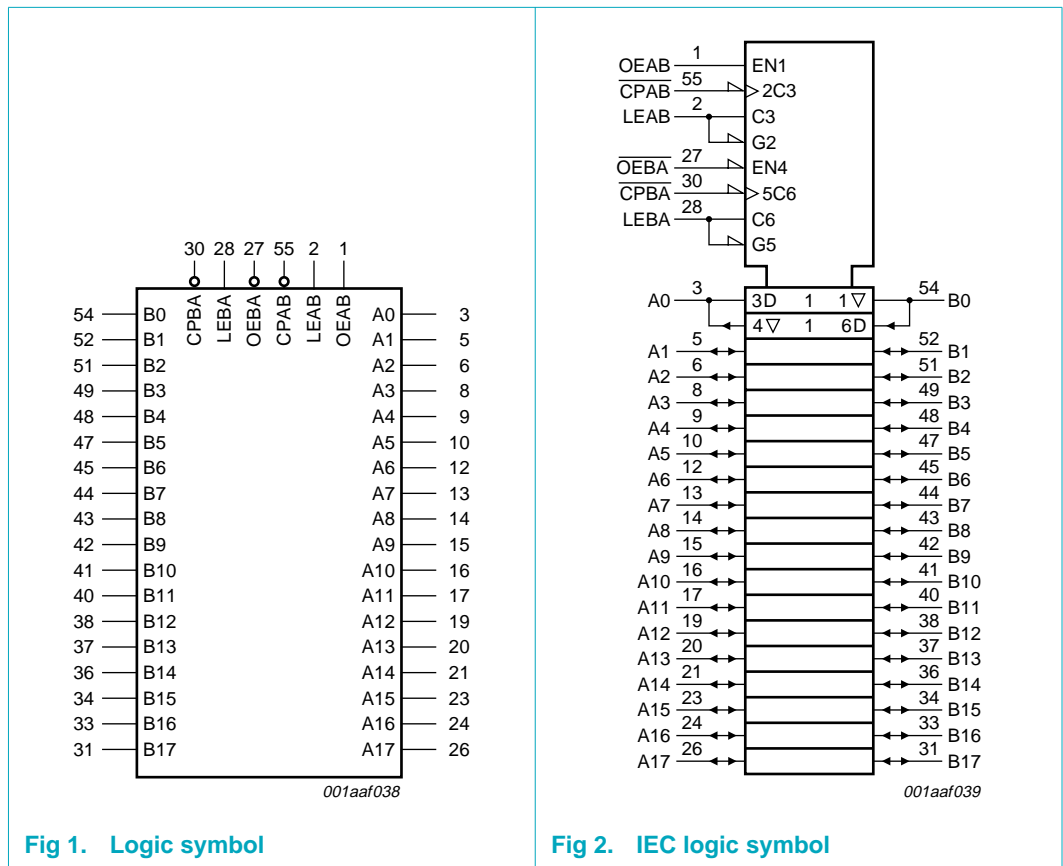
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3. Ordering information

Table 1. Ordering information

Type number	Package			Version
	Temperature range	Name	Description	
74LVT16500ADGG	-40 °C to +85 °C	TSSOP56	plastic thin shrink small outline package; 56 leads; body width 6.1 mm	SOT364-1
74LVT16500ADL	-40 °C to +85 °C	SSOP56	plastic shrink small outline package; 56 leads; body width 7.5 mm	SOT371-1

4. Functional diagram



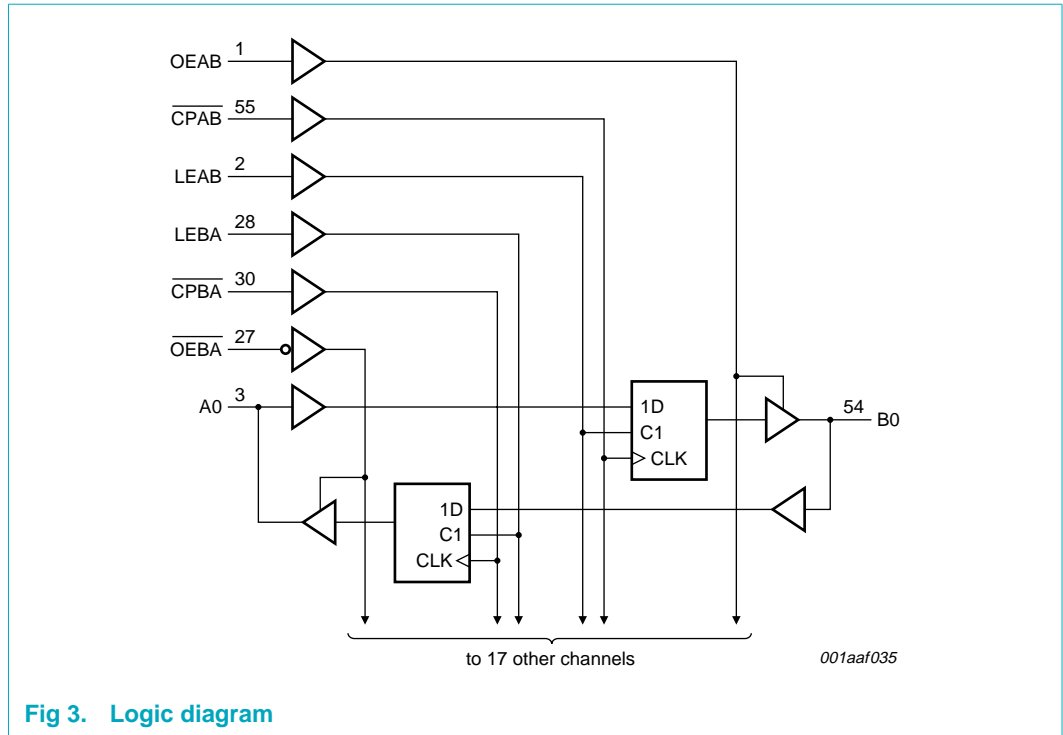
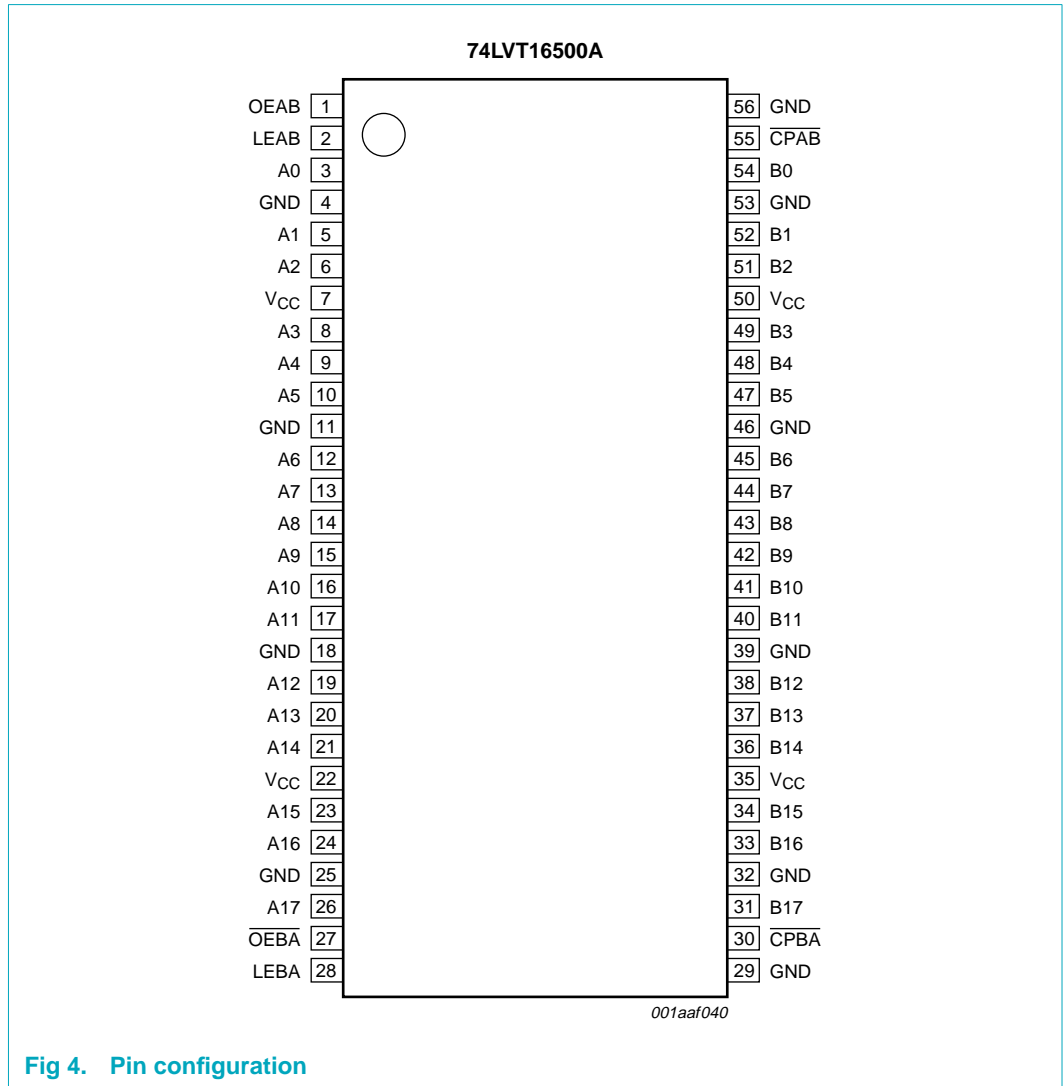


Fig 3. Logic diagram

5. Pinning information

5.1 Pinning



5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
OEAB	1	A-to-B output enable input
LEAB	2	A-to-B latch enable input
A0	3	data input/output A0
GND	4	ground (0 V)
A1	5	data input/output A1
A2	6	data input/output A2
Vcc	7	supply voltage

Table 2. Pin description ...continued

Symbol	Pin	Description
A3	8	data input/output A3
A4	9	data input/output A4
A5	10	data input/output A5
GND	11	ground (0 V)
A6	12	data input/output A6
A7	13	data input/output A7
A8	14	data input/output A8
A9	15	data input/output A9
A10	16	data input/output A10
A11	17	data input/output A11
GND	18	ground (0 V)
A12	19	data input/output A12
A13	20	data input/output A13
A14	21	data input/output A14
V _{CC}	22	supply voltage
A15	23	data input/output A15
A16	24	data input/output A16
GND	25	ground (0 V)
A17	26	data input/output A17
\overline{OEBA}	27	B-to-A output enable input (active LOW)
LEBA	28	B-to-A latch enable input
GND	29	ground (0 V)
\overline{CPBA}	30	B-to-A clock input (active falling edge)
B17	31	data input/output B17
GND	32	ground (0 V)
B16	33	data input/output B16
B15	34	data input/output B15
V _{CC}	35	supply voltage
B14	36	data input/output B14
B13	37	data input/output B13
B12	38	data input/output B12
GND	39	ground (0 V)
B11	40	data input/output B11
B10	41	data input/output B10
B9	42	data input/output B9
B8	43	data input/output B8
B7	44	data input/output B7
B6	45	data input/output B6
GND	46	ground (0 V)
B5	47	data input/output B5
B4	48	data input/output B4

Table 2. Pin description ...continued

Symbol	Pin	Description
B3	49	data input/output B3
V _{CC}	50	supply voltage
B2	51	data input/output B2
B1	52	data input/output B1
GND	53	ground (0 V)
B0	54	data input/output B0
$\overline{\text{CPAB}}$	55	A-to-B clock input (active falling edge)
GND	56	ground (0 V)

6. Functional description

Table 3. Function table^[1]

Operating mode	Control			Input	Internal register	Output
	OEAB	LEAB	$\overline{\text{CPAB}}$	A _n		B _n
	$\overline{\text{OEBA}}$	LEBA	$\overline{\text{CPBA}}$	B _n		A _n
disabled	L	H	X	X	X	Z
disabled, latch data	L	↓	X	h	H	Z
disabled, latch data	L	↓	X	l	L	Z
disabled, hold data	L	L	H or L	X	NC	Z
disabled, clock data	L	L	↓	h	H	Z
disabled, clock data	L	L	↓	l	L	Z
transparent	H	H	X	H	H	H
transparent	H	H	X	L	L	L
latch data and display	H	↓	X	h	H	H
latch data and display	H	↓	X	l	L	L
clock data and display	H	L	↓	h	H	H
clock data and display	H	L	↓	l	L	L
hold data and display	H	L	H or L	X	H	H
hold data and display	H	L	H or L	X	L	L

- [1] H = HIGH voltage level;
h = HIGH voltage level one setup time prior to the enable or clock transition;
L = LOW voltage level;
l = LOW voltage level one setup time prior to the enable or clock transition;
NC = no change;
X = don't care;
Z = high-impedance OFF-state;
↓ = HIGH-to-LOW enable or clock transition.

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CC}	supply voltage		-0.5	+4.6	V
V_I	input voltage		[1] -0.5	+7.0	V
V_O	output voltage	output in OFF-state or HIGH-state	[1] -0.5	+7.0	V
I_{IK}	input clamping current	$V_I < 0$ V	-	-50	mA
I_{OK}	output clamping current	$V_O < 0$ V	-	-50	mA
I_O	output current	output in LOW-state	-	128	mA
		output in HIGH-state	-	-64	mA
T_{stg}	storage temperature		-65	+150	°C
T_j	junction temperature		[2] -	150	°C

[1] The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

[2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability.

8. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{CC}	supply voltage		2.7	-	3.6	V
V_I	input voltage		0	-	5.5	V
V_{IH}	HIGH-level input voltage		2.0	-	-	V
V_{IL}	LOW-level input voltage		-	-	0.8	V
I_{OH}	HIGH-level output current		-	-	-32	mA
I_{OL}	LOW-level output current	none	-	-	32	mA
		current duty cycle ≤ 50 %; $f_i \geq 1$ kHz	-	-	64	mA
$\Delta t/\Delta V$	input transition rise and fall rate	outputs enabled	-	-	10	ns/V
T_{amb}	ambient temperature	in free air	-40	-	+85	°C

9. Static characteristics

Table 6. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$T_{amb} = -40\text{ °C to }85\text{ °C}$^[1]						
V_{IK}	input clamping voltage	$V_{CC} = 2.7\text{ V}; I_{IK} = -18\text{ mA}$	-	-0.85	-1.2	V
V_{OH}	HIGH-level output voltage	$V_{CC} = 2.7\text{ V to }3.6\text{ V}; I_{OH} = -100\text{ }\mu\text{A}$	$V_{CC} - 0.2$	V_{CC}	-	V
		$V_{CC} = 2.7\text{ V}; I_{OH} = -8\text{ mA}$	2.4	2.55	-	V
		$V_{CC} = 3.0\text{ V}; I_{OH} = -32\text{ mA}$	2.0	2.3	-	V
V_{OL}	LOW-level output voltage	$V_{CC} = 2.7\text{ V}$				
		$I_{OL} = 100\text{ }\mu\text{A}$	-	0.07	0.2	V
		$I_{OL} = 24\text{ mA}$	-	0.3	0.5	V
		$V_{CC} = 3.0\text{ V}$				
		$I_{OL} = 16\text{ mA}$	-	0.25	0.4	V
		$I_{OL} = 32\text{ mA}$	-	0.3	0.5	V
V_{RST}	power-up output low voltage	$V_{CC} = 3.6\text{ V}; I_O = 1\text{ mA}; V_I = V_{CC}\text{ or GND}$	^[2] -	0.1	0.55	V
I_{LI}	input leakage current	control pins				
		$V_{CC} = 3.6\text{ V}; V_I = V_{CC}\text{ or GND}$	-	0.1	± 1	μA
		$V_{CC} = 0\text{ V or }3.6\text{ V}; V_I = 5.5\text{ V}$	-	0.1	10	μA
	I/O data pins	$V_{CC} = 3.6\text{ V}$	^[3]			
		$V_I = 5.5\text{ V}$	-	1.0	20	μA
$V_I = V_{CC}$		-	0.1	10	μA	
	$V_I = 0\text{ V}$	-	+0.1	-5	μA	
I_{OFF}	power-off leakage current	$V_{CC} = 0\text{ V}; V_I\text{ or }V_O = 0\text{ V to }4.5\text{ V}$	-	1.0	± 100	μA
I_{HOLD}	bus hold current data input	$V_{CC} = 3\text{ V}$	^[4]			
		$V_I = 0.8\text{ V}$	75	130	-	μA
		$V_I = 2.0\text{ V}$	-75	-130	-	μA
		$V_I = 0\text{ V to }3.6\text{ V}; V_{CC} = 3.6\text{ V}$	± 500	-	-	μA
I_{EX}	external current into output	output in the HIGH-state when $V_O > V_{CC}$; $V_O = 5.5\text{ V}; V_{CC} = 3.0\text{ V}$	-	50	125	μA
$I_{O(pu/pd)}$	power-up/power-down output current	$V_{CC} \leq 1.2\text{ V}; V_O = 0.5\text{ V to }V_{CC}; V_I = \text{GND or }V_{CC}$; OEAB or $\overline{\text{OEBA}}$ don't care	^[5] -	40	± 100	μA
I_{CC}	quiescent supply current	$V_{CC} = 3.6\text{ V}; V_I = \text{GND or }V_{CC}; I_O = 0\text{ A}$				
		outputs HIGH-state	-	0.07	0.12	mA
		outputs LOW-state	-	4	6	mA
		outputs disabled	^[6] -	0.07	0.12	mA

Table 6. Static characteristics ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
ΔI_{CC}	additional quiescent supply current	per input pin; $V_{CC} = 3\text{ V to }3.6\text{ V}$; one input at $V_{CC} - 0.6\text{ V}$; other inputs at V_{CC} or GND	[7] -	0.1	0.2	mA
C_i	input capacitance	control pins; $V_I = 0\text{ V or }3.0\text{ V}$	-	3	-	pF
C_{io}	input/output capacitance	I/O pins; $V_{I/O} = 0\text{ V or }3.0\text{ V}$	-	9	-	pF

- [1] Typical values are at $V_{CC} = 3.3\text{ V}$ and $T_{amb} = 25\text{ }^\circ\text{C}$.
- [2] For valid test results, data must not be loaded into the flip-flops (or latches) after applying power.
- [3] Unused pins at V_{CC} or GND.
- [4] This is the bus hold overdrive current required to force the input to the opposite logic state.
- [5] This parameter is valid for any V_{CC} between 0 V and 1.2 V with a transition time of up to 10 ms. From $V_{CC} = 1.2\text{ V}$ to $V_{CC} = 3.0\text{ V} \pm 0.3\text{ V}$ a transition time of 100 μs is permitted. This parameter is valid for $T_{amb} = 25\text{ }^\circ\text{C}$ only.
- [6] I_{CC} is measured with outputs pulled to V_{CC} or GND.
- [7] This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND.

10. Dynamic characteristics

Table 7. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V); for test circuit see [Figure 11](#).

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{CC} = 2.7\text{ V}$; $T_{amb} = -40\text{ }^\circ\text{C to }85\text{ }^\circ\text{C}$						
t_{PLH}	propagation delay					
	An to Bn or Bn to An	see Figure 5	-	-	5.4	ns
	\overline{CPAB} to Bn or \overline{CPBA} to An	see Figure 6	-	-	6.4	ns
	LEAB to Bn or LEBA to An	see Figure 7	-	-	6.4	ns
t_{PHL}	propagation delay					
	An to Bn or Bn to An	see Figure 5	-	-	5.4	ns
	\overline{CPAB} to Bn or \overline{CPBA} to An	see Figure 6	-	-	6.4	ns
	LEAB to Bn or LEBA to An	see Figure 7	-	-	6.4	ns
t_{PZH}	output enable time to HIGH-level	see Figure 8	-	-	5.5	ns
t_{PZL}	output enable time to LOW-level	see Figure 9	-	-	5.2	ns
t_{PHZ}	output disable time from HIGH-level	see Figure 8	-	-	6.3	ns
t_{PLZ}	output disable time from LOW-level	see Figure 9	-	-	5.6	ns
$t_{su(H)}$	setup time HIGH					
	An to \overline{CPAB} or Bn to \overline{CPBA}	see Figure 10	2.5	-	-	ns
	An to LEAB with \overline{CPAB} LOW or Bn to LEBA with \overline{CPBA} LOW	see Figure 10	2.2	-	-	ns
	An to LEAB with \overline{CPAB} HIGH or Bn to LEBA with \overline{CPBA} HIGH	see Figure 10	2.7	-	-	ns

Table 7. Dynamic characteristics ...continuedVoltages are referenced to GND (ground = 0 V); for test circuit see [Figure 11](#).

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$t_{su(L)}$	setup time LOW					
	An to \overline{CPAB} or Bn to \overline{CPBA}	see Figure 10	2.5	-	-	ns
	An to LEAB with \overline{CPAB} LOW or Bn to LEBA with \overline{CPBA} LOW	see Figure 10	2.2	-	-	ns
	An to LEAB with \overline{CPAB} HIGH or Bn to LEBA with \overline{CPBA} HIGH	see Figure 10	2.7	-	-	ns
$t_{h(H)}$	hold time HIGH					
	An to \overline{CPAB} or Bn to \overline{CPBA}	see Figure 10	0	-	-	ns
	An to LEAB or Bn to LEBA	see Figure 10	0	-	-	ns
$t_{h(L)}$	hold time LOW					
	An to \overline{CPAB} or Bn to \overline{CPBA}	see Figure 10	0	-	-	ns
	An to LEAB or Bn to LEBA	see Figure 10	0	-	-	ns
t_{WH}	pulse width HIGH					
	\overline{CPAB} or \overline{CPBA}	see Figure 6	1.5	-	-	ns
	LEAB or LEBA	see Figure 7	1.5	-	-	ns
t_{WL}	pulse width LOW					
	\overline{CPAB} or \overline{CPBA}	see Figure 6	1.5	-	-	ns
$V_{CC} = 3.0\text{ V} \pm 0.3\text{ V}$; $T_{amb} = -40\text{ }^{\circ}\text{C}$ to $85\text{ }^{\circ}\text{C}$[1]						
t_{PLH}	propagation delay					
	An to Bn or Bn to An	see Figure 5	0.5	1.9	4.2	ns
	\overline{CPAB} to Bn or \overline{CPBA} to An	see Figure 6	1.0	3.2	5.4	ns
	LEAB to Bn or LEBA to An	see Figure 7	1.0	2.4	5.4	ns
t_{PHL}	propagation delay					
	An to Bn or Bn to An	see Figure 5	0.5	1.9	4.2	ns
	\overline{CPAB} to Bn or \overline{CPBA} to An	see Figure 6	1.0	3.2	5.4	ns
	LEAB to Bn or LEBA to An	see Figure 7	1.0	2.9	5.4	ns
t_{PZH}	output enable time to HIGH-level	see Figure 8	1.0	2.4	4.8	ns
t_{PZL}	output enable time to LOW-level	see Figure 9	1.0	2.2	4.8	ns
t_{PHZ}	output disable time from HIGH-level	see Figure 8	1.0	2.8	5.8	ns
t_{PLZ}	output disable time from LOW-level	see Figure 9	1.0	3.2	5.2	ns
$t_{su(H)}$	setup time HIGH					
	An to \overline{CPAB} or Bn to \overline{CPBA}	see Figure 10	2.4	1.0	-	ns
	An to LEAB with \overline{CPAB} LOW or Bn to LEBA with \overline{CPBA} LOW	see Figure 10	2.3	0.9	-	ns
	An to LEAB with \overline{CPAB} HIGH or Bn to LEBA with \overline{CPBA} HIGH	see Figure 10	2.4	0.9	-	ns
$t_{su(L)}$	setup time LOW					
	An to \overline{CPAB} or Bn to \overline{CPBA}	see Figure 10	2.4	0.7	-	ns
	An to LEAB with \overline{CPAB} LOW or Bn to LEBA with \overline{CPBA} LOW	see Figure 10	2.3	0.9	-	ns
	An to LEAB with \overline{CPAB} HIGH or Bn to LEBA with \overline{CPBA} HIGH	see Figure 10	2.4	0.8	-	ns

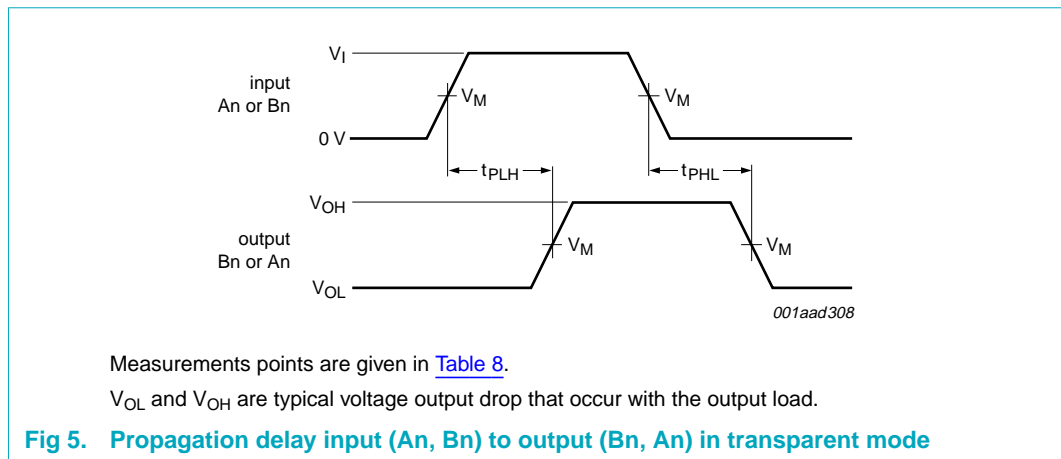
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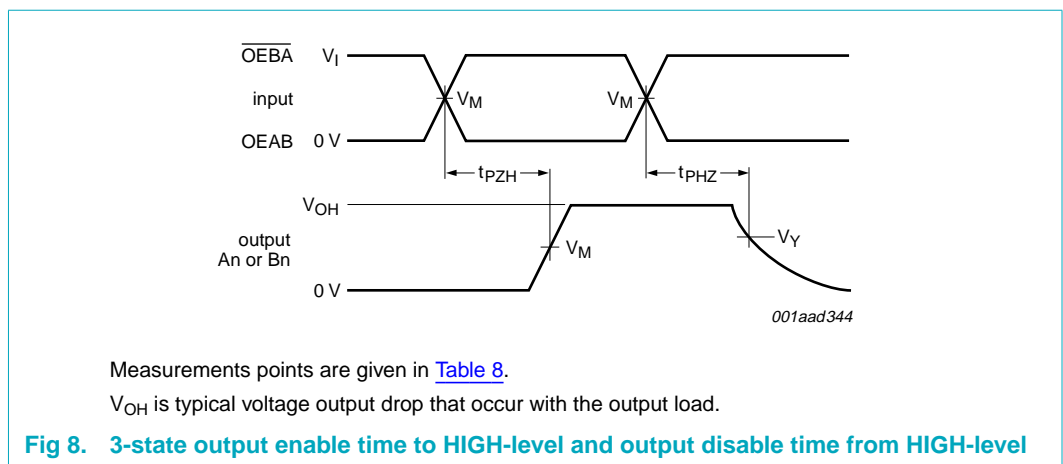
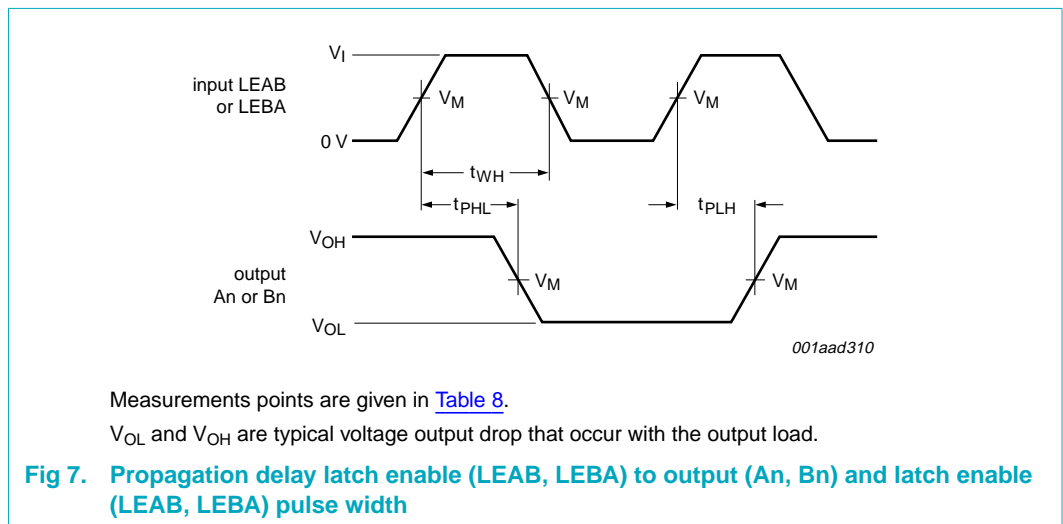
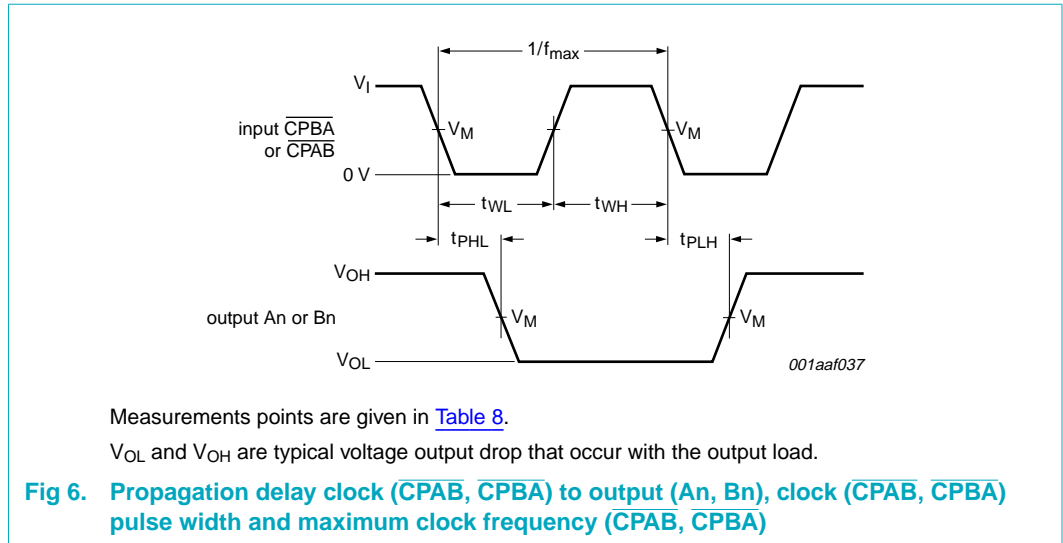
Voltages are referenced to GND (ground = 0 V); for test circuit see [Figure 11](#).

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$t_{h(H)}$	hold time HIGH					
	An to \overline{CPAB} or Bn to \overline{CPBA}	see Figure 10	0	0	-	ns
	An to LEAB or Bn to LEBA	see Figure 10	0	0	-	ns
$t_{h(L)}$	hold time LOW					
	An to \overline{CPAB} or Bn to \overline{CPBA}	see Figure 10	0	0	-	ns
	An to LEAB or Bn to LEBA	see Figure 10	0	0	-	ns
t_{WH}	pulse width HIGH					
	\overline{CPAB} or \overline{CPBA}	see Figure 6	1.2	0.8	-	ns
	LEAB or LEBA	see Figure 7	1.2	0.8	-	ns
t_{WL}	pulse width LOW					
	\overline{CPAB} or \overline{CPBA}	see Figure 6	1.2	0.8	-	ns
f_{max}	maximum input clock frequency	see Figure 6	150	350	-	MHz

[1] All typical values are measured at $V_{CC} = 3.3$ V and $T_{amb} = 25$ °C.

11. Waveforms





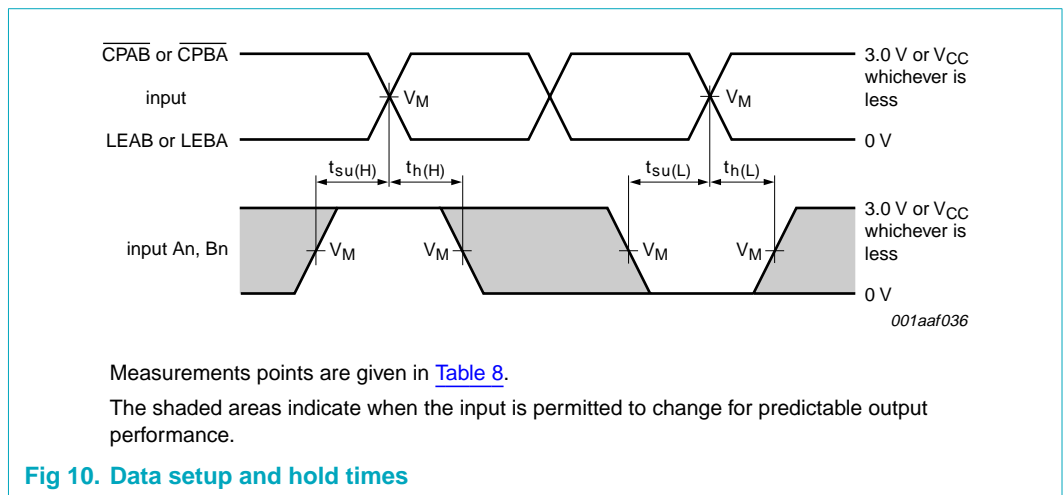
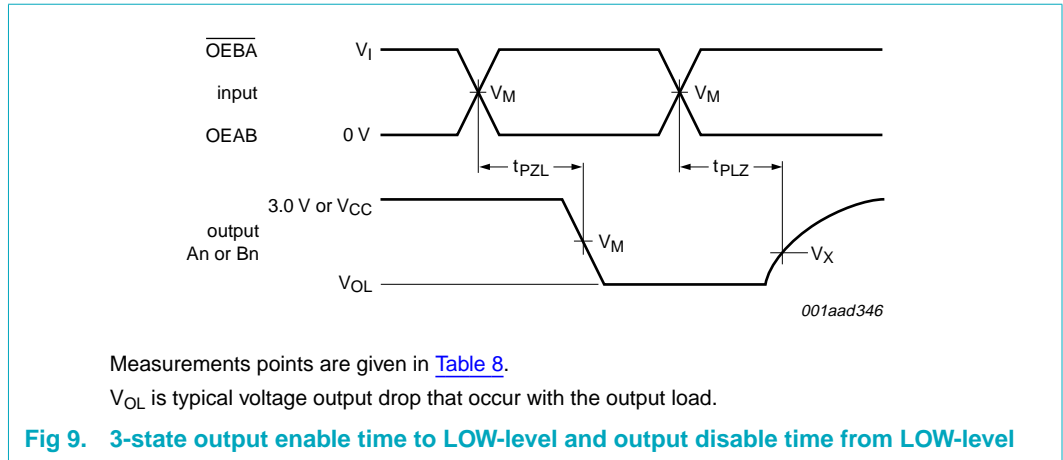


Table 8. Measurement points

Supply voltage	Input	Output		
	V_M	V_M	V_X	V_Y
2.7 V	1.5 V	1.5 V	$V_{OL} + 0.3 V$	$V_{OH} - 0.3 V$
3.3 V	1.5 V	1.5 V	$V_{OL} + 0.3 V$	$V_{OH} - 0.3 V$

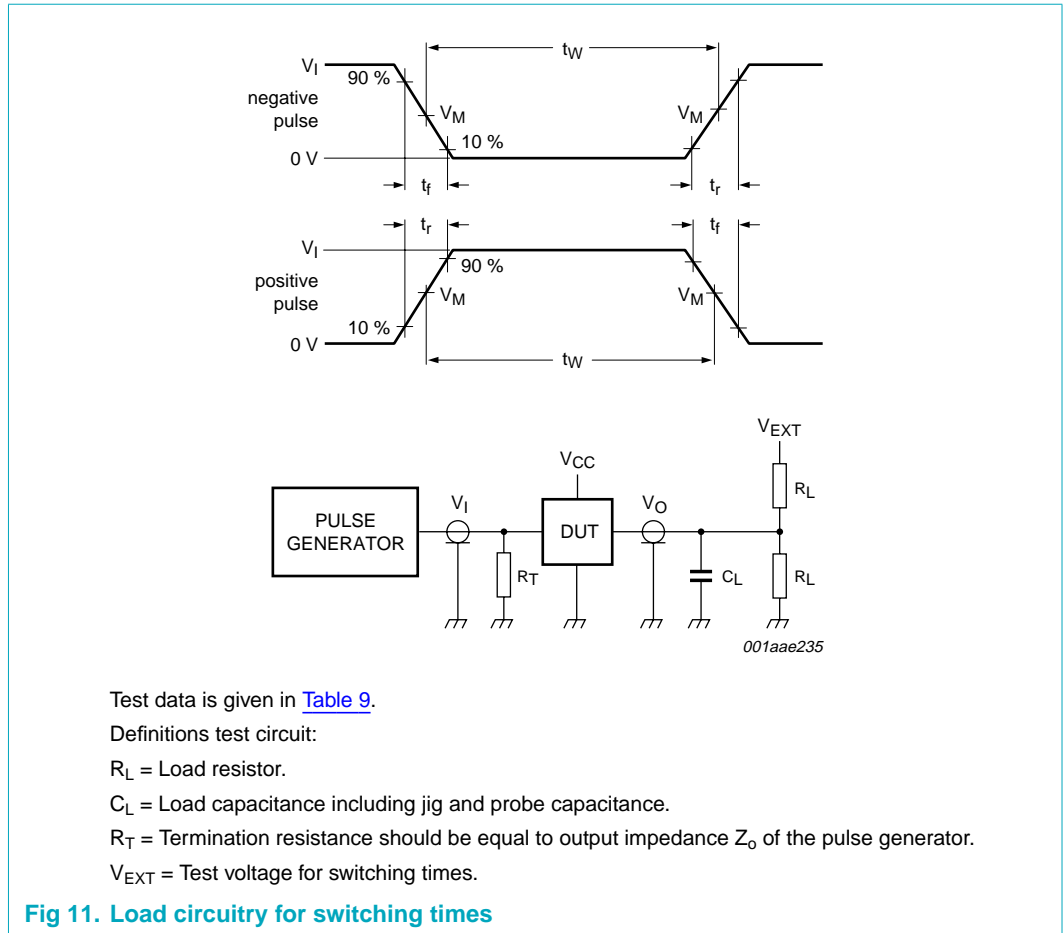


Table 9. Test data

Input				Load		V_{EXT}		
V_I	f_i	t_W	t_r, t_f	C_L	R_L	t_{PHZ}, t_{PZH}	t_{PLZ}, t_{PZL}	t_{PLH}, t_{PHL}
2.7 V	≤ 10 MHz	500 ns	≤ 2.5 ns	50 pF	500 Ω	GND	6 V	open

12. Package outline

TSSOP56: plastic thin shrink small outline package; 56 leads; body width 6.1 mm

SOT364-1

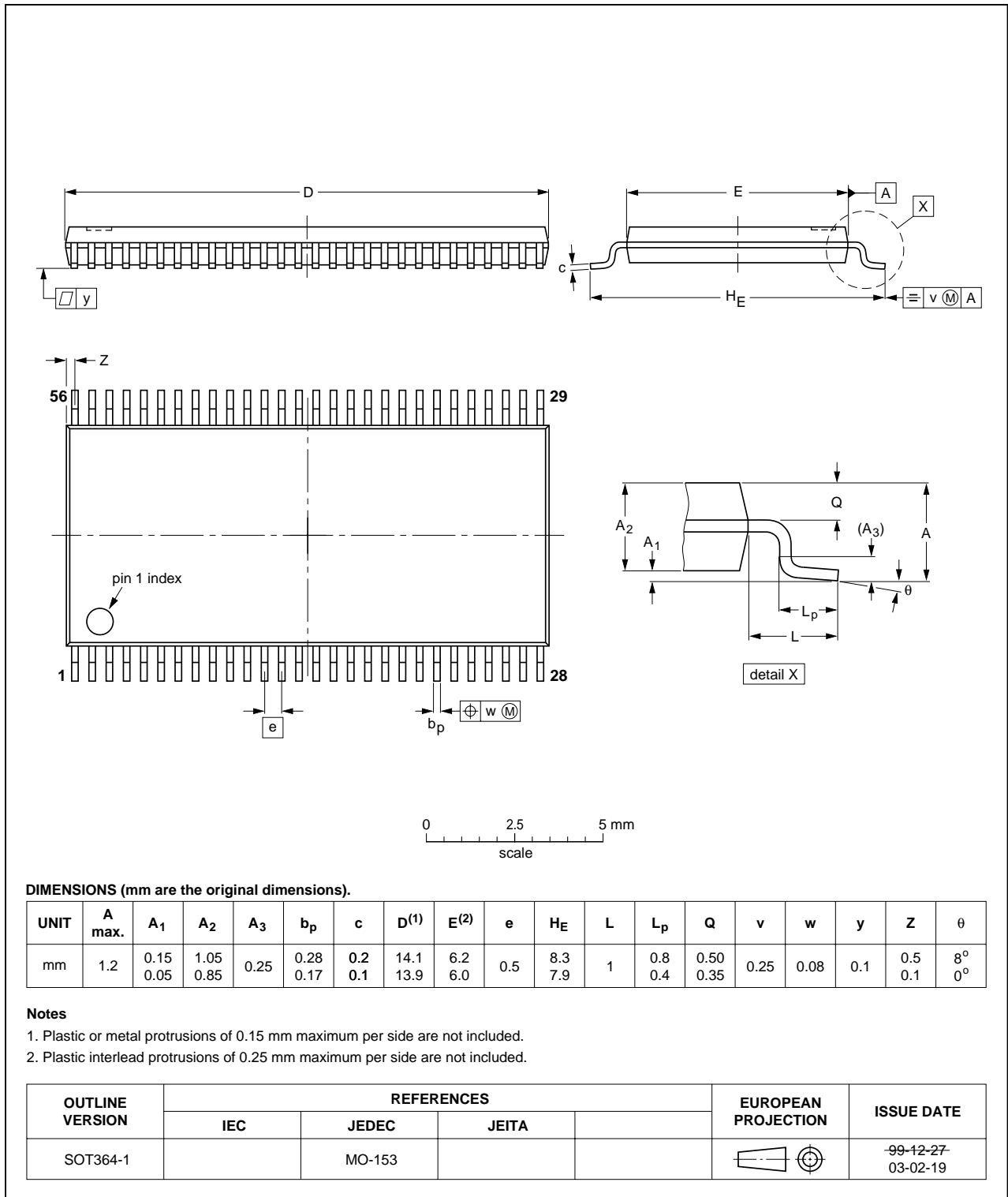


Fig 12. Package outline SOT364-1 (TSSOP56)

SSOP56: plastic shrink small outline package; 56 leads; body width 7.5 mm

SOT371-1

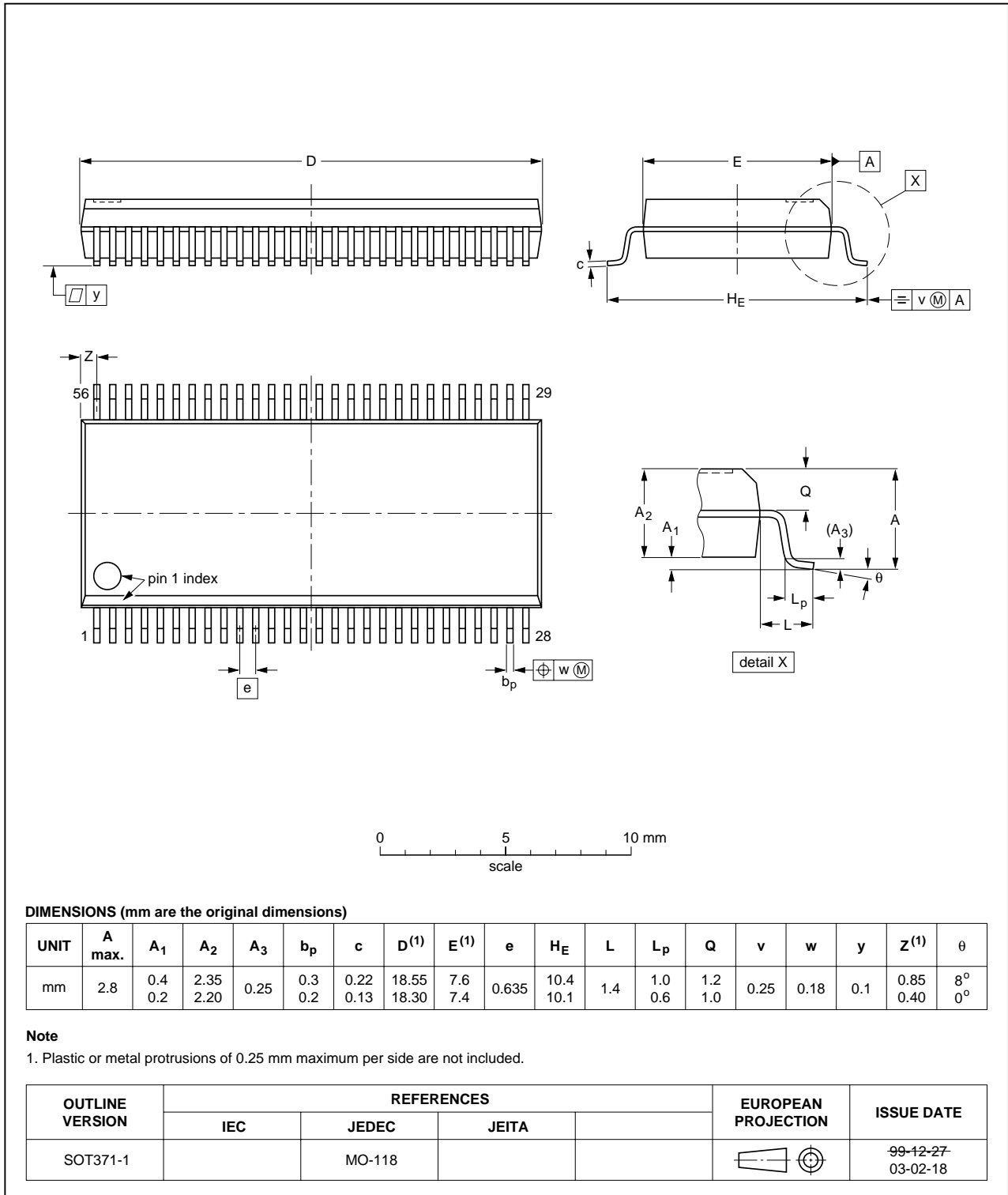


Fig 13. Package outline SOT371-1 (SSOP56)

13. Abbreviations

Table 10. Abbreviations

Acronym	Description
BiCMOS	Bipolar Complementary Metal Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
TTL	Transistor-Transistor Logic

14. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74LVT16500A_3	20060529	Product data sheet	-	74LVT16500A_2
Modifications:	<ul style="list-style-type: none"> The format of this data sheet has been redesigned to comply with the new presentation and information standard of Philips Semiconductors Section 2 “Features”: replaced JEDEC JC40.2 Std 17 with JESD78 Figure 3 “Logic diagram”: corrected clock names and pin names Table 7 “Dynamic characteristics”: splitting up $t_{su(H)}$ and $t_{su(L)}$ parameter ‘An to LEAB or Bn to LEBA’ in 2 parameters with clock conditions and new values 			
74LVT16500A_2 (9397 750 03556)	19980219	Product specification	-	74LVT16500A_1
74LVT16500A_1	19970612	Product specification	-	74LVT16500A
74LVT16500A	19950320	Product specification	-	-

15. Legal information

15.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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